Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/501,302	NEUPART, LARS	
Examiner	Art Unit	
Shin-Hon Chen	2131	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date .	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	6/29/2007	S.C.
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